## Applicant(s)/Patent Under Reexamination Application/Control No. 10/670,532 OGAWA ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2818 David Lam

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,597,629	07-2003	Raszka et al.	365/233
	В	US-			
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	К	US-			
	L	US-			
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## **NON-PATENT DOCUMENTS**

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